

Notice of References Cited	Application/Control No. 10/783,763		Applicant(s)/Patent Under Reexamination LEE, WHONCHEE	
	Examiner Kin-Chan Chen		Art Unit 1765	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0054729	03-2003	Lee et al.	451/5
*	B	US-2005/0178743	08-2005	Manens et al.	216/088
*	C	US-6,848,970	02-2005	Manens et al.	451/5
*	D	US-2005/0173260	08-2005	Basol et al.	205/662
*	E	US-2005/0133379	06-2005	Basol et al.	205/652
*	F	US-2004/0259479	12-2004	Sevilla, Roland K.	451/041
*	G	US-2004/0214510	10-2004	So, Joseph K.	451/041
*	H	US-6,893,328	05-2005	So, Joseph K.	451/41
*	I	US-6,852,630	02-2005	Basol et al.	438/691
*	J	US-6,867,136	03-2005	Basol et al.	438/687
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.